



US00D788612S

(12) **United States Design Patent** (10) **Patent No.:** **US D788,612 S**
Lafrance et al. (45) **Date of Patent:** **** Jun. 6, 2017**

(54) **MODULAR TEST INSTRUMENT**

(71) Applicant: **EXFO INC.**, Quebec (CA)

(72) Inventors: **Denis Lafrance**, Quebec (CA);
Antoine-Alexandre Michaud, Quebec (CA)

(73) Assignee: **EXFO INC.**, Quebec (CA)

(**) Term: **15 Years**

(21) Appl. No.: **29/554,373**

(22) Filed: **Feb. 11, 2016**

(51) **LOC (10) Cl.** **10-04**

(52) **U.S. Cl.**
USPC **D10/75; D10/81**

(58) **Field of Classification Search**
USPC D10/75, 76, 81
CPC H04B 17/00; H04H 20/12; H04L 43/045;
H04C 43/50

See application file for complete search history.

(56) **References Cited**

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Primary Examiner — Antoine D Davis

(74) *Attorney, Agent, or Firm* — Norton Rose Fulbright Canada LLP; Alexandre Daoust

(57) **CLAIM**

The ornamental design for a modular test instrument, as shown and described.

DESCRIPTION

FIG. 1 is an oblique view, taken from the front and from above, of a first variant of a modular test instrument showing my new design;

FIG. 2 is another oblique view thereof, taken from the rear and from below;

FIG. 3 is a front elevation view thereof;

FIG. 4 is a rear elevation view thereof;

FIG. 5 is a left side elevation view thereof;

FIG. 6 is a right sider elevation view thereof;

FIG. 7 is a top plan view thereof;

FIG. 8 is a bottom plan thereof;

FIG. 9 is an oblique view, taken from the front and from above, of a second variant of a modular test instrument showing my new design;

FIG. 10 is another oblique view thereof, taken from the rear and from below;

FIG. 11 is a front elevation view thereof;

FIG. 12 is a rear elevation view thereof;

FIG. 13 is a left side elevation view thereof;

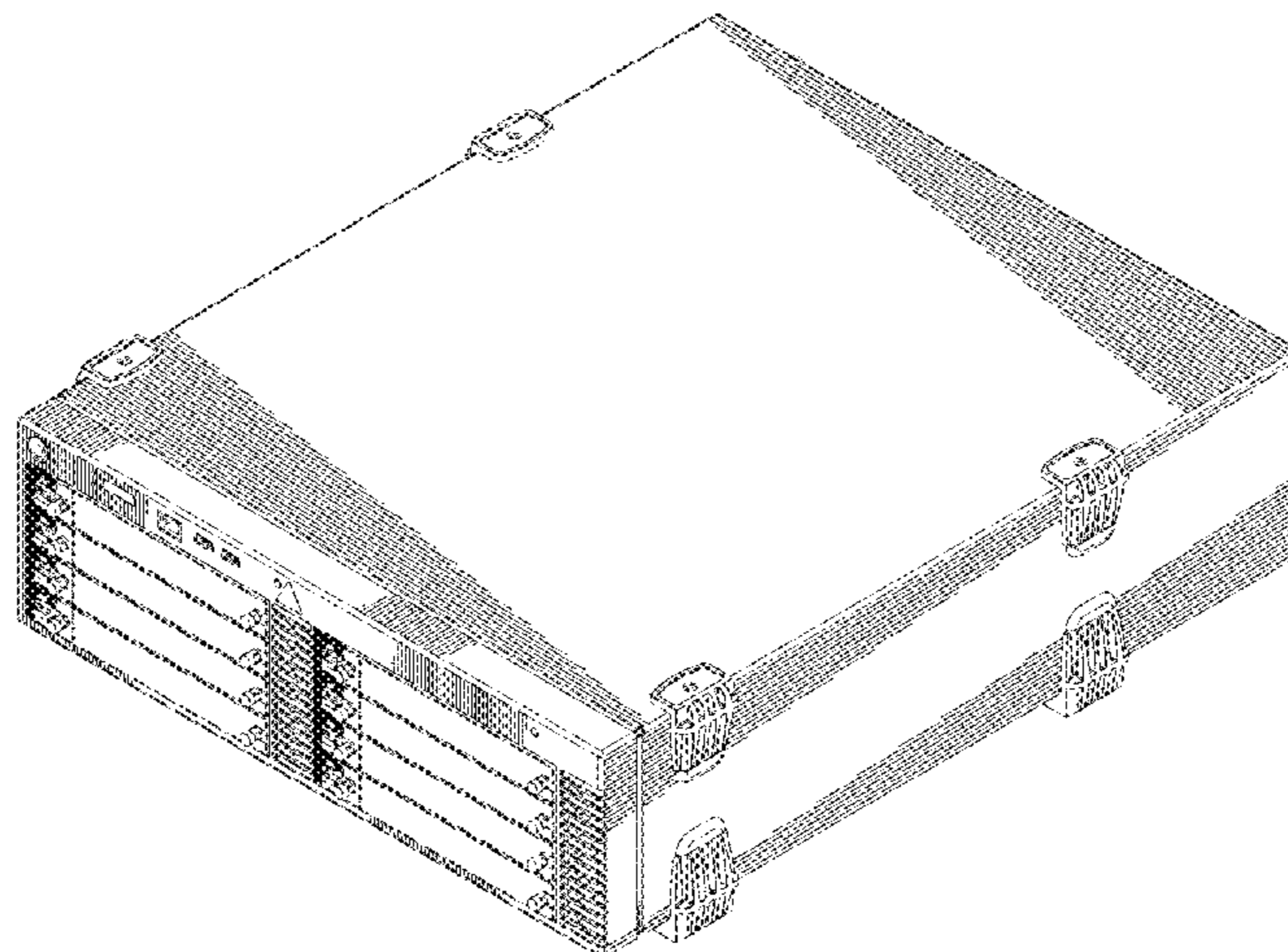
FIG. 14 is a right sider elevation view thereof;

FIG. 15 is a top plan view thereof; and,

FIG. 16 is a bottom plan thereof.

The dashed line showing of structural lines is included for the purpose of illustrating non-claimed subject matter and forms no part of the claimed design. Line shading is used to better illustrate the three-dimensional contours of portions of the modular test instrument. Solid black, and horizontal stippled hashing surface treatment is used to show contrast between a dark tone and a light tone, respectively, in accordance with 37 CFR 1.152, MPEP 1503.02 (II and IV), and MPEP 608.02 IX.

1 Claim, 12 Drawing Sheets



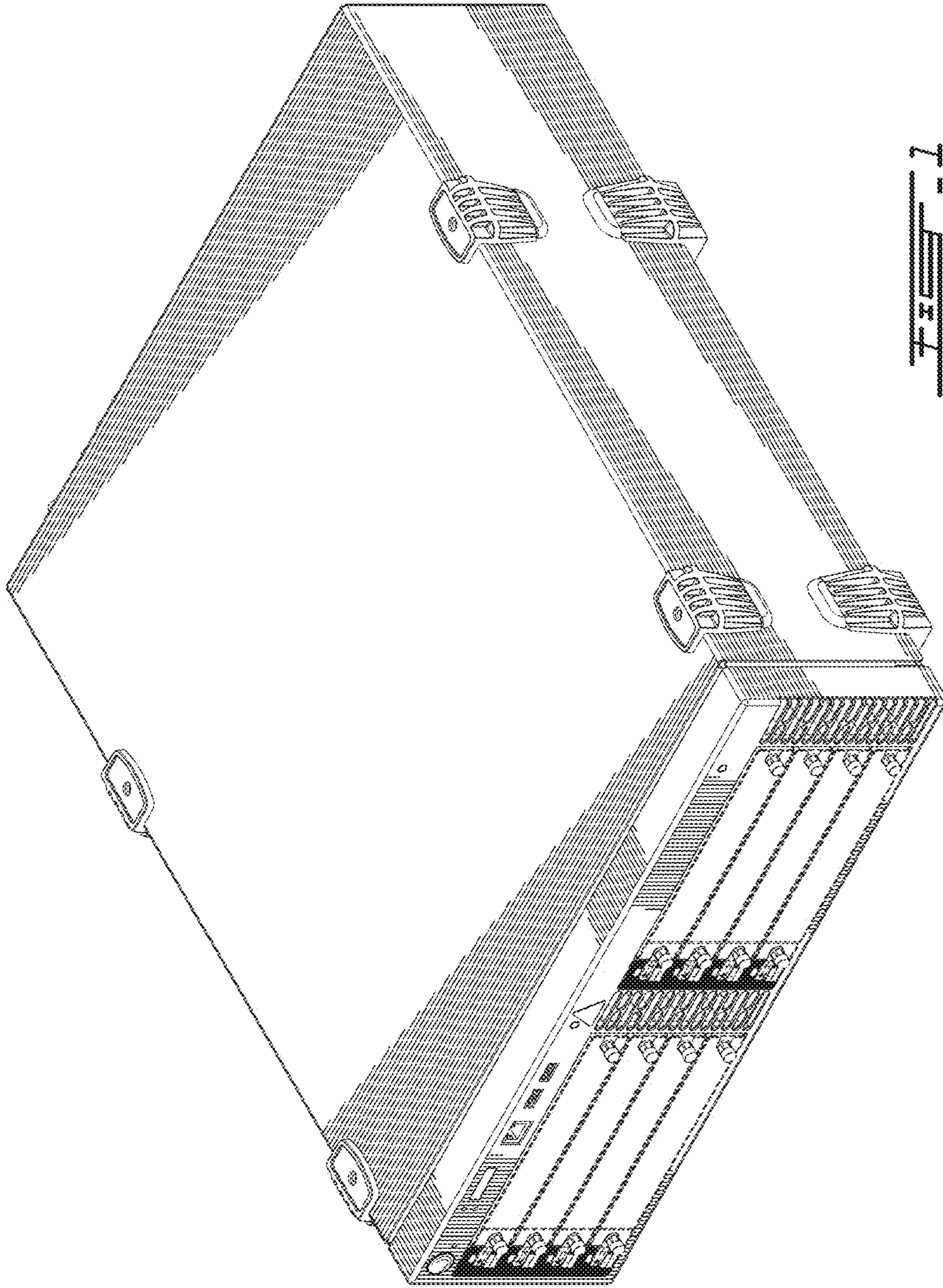
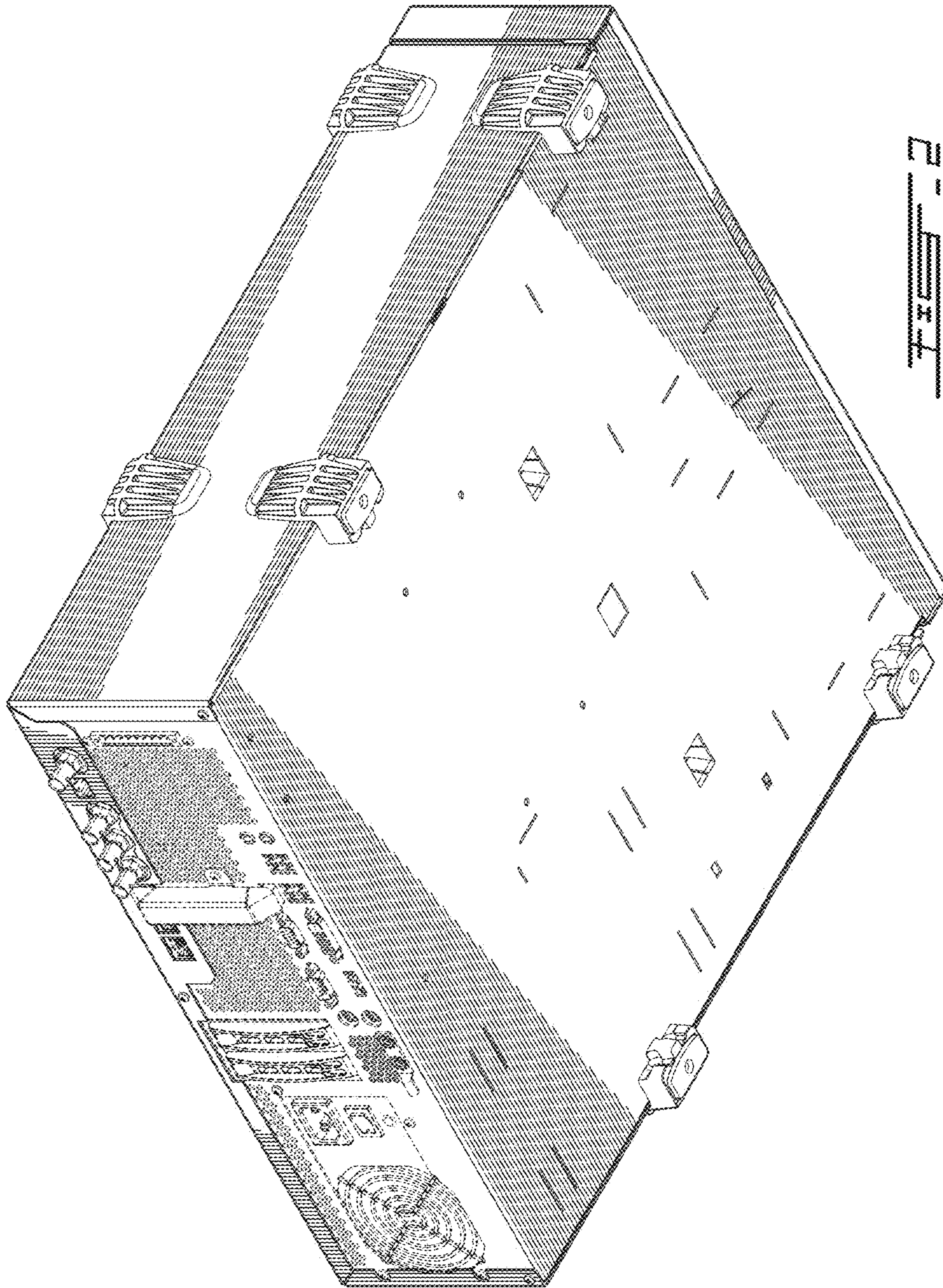


FIG. 1



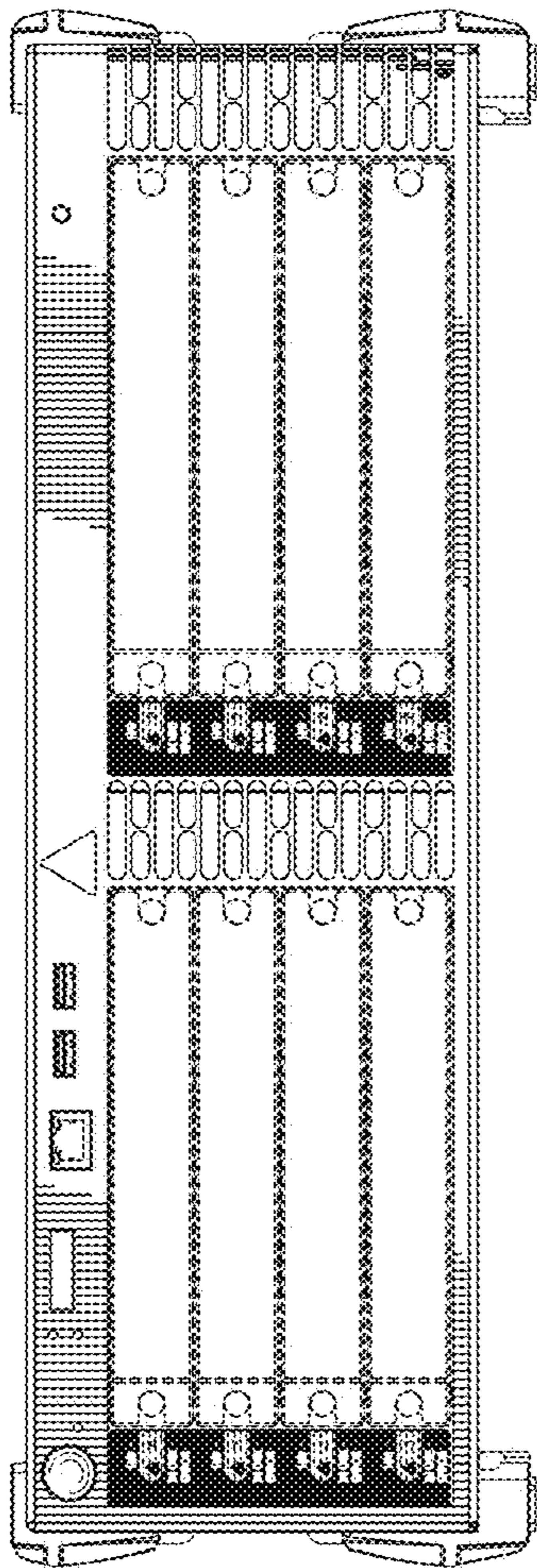


FIG. 3

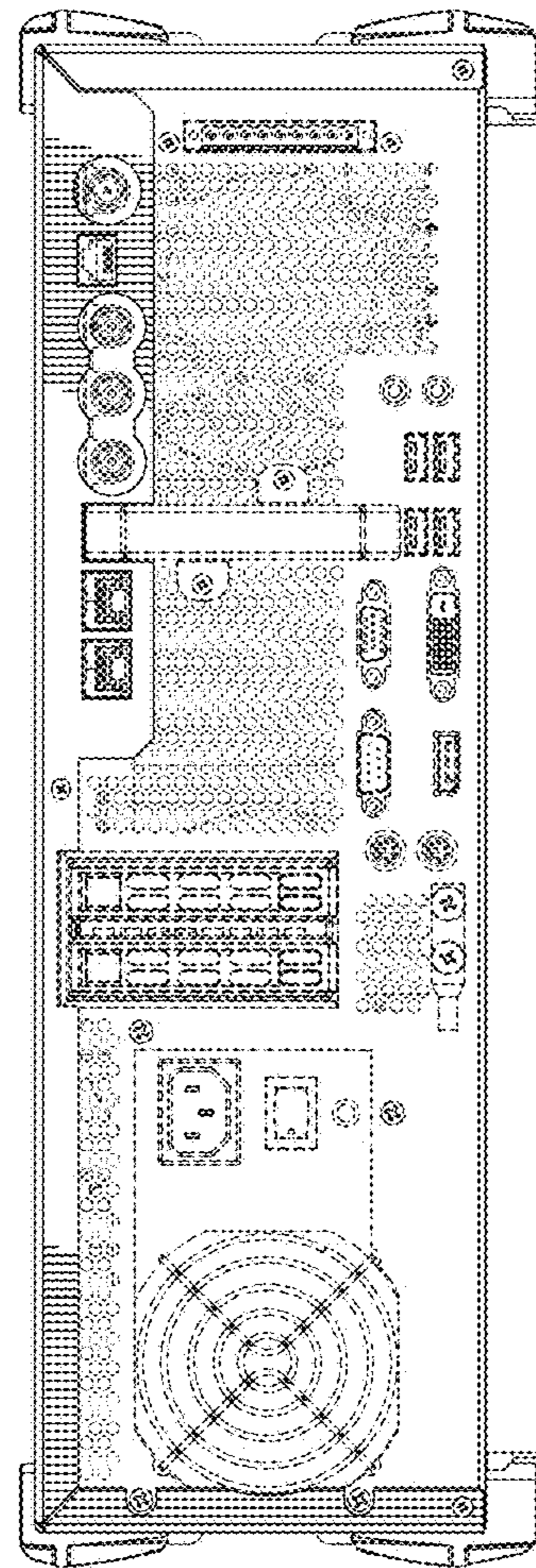


FIG. 4

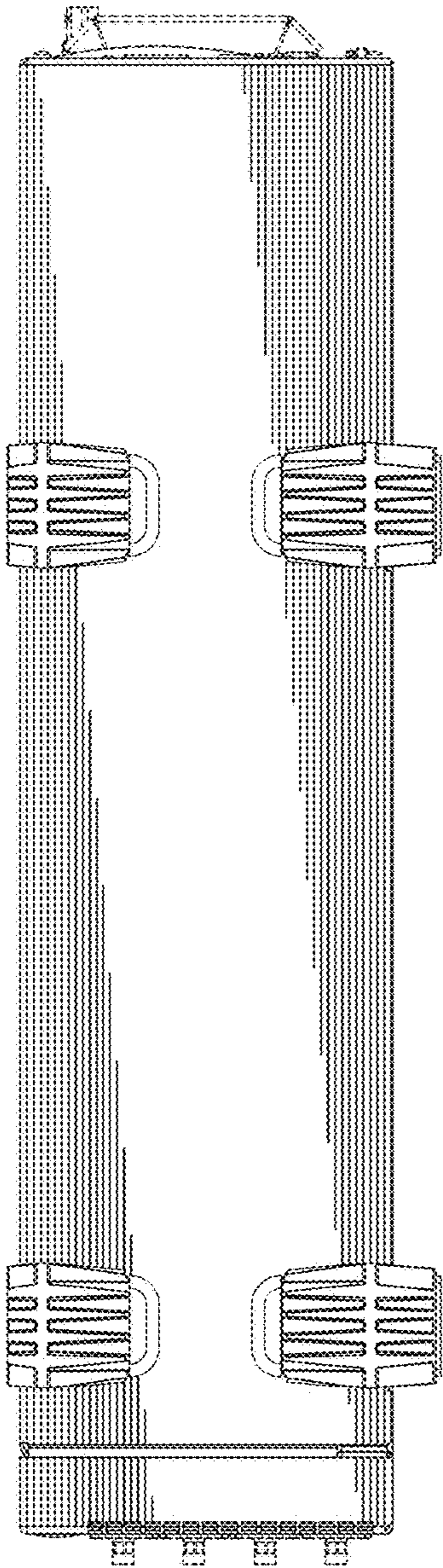


FIG. 5

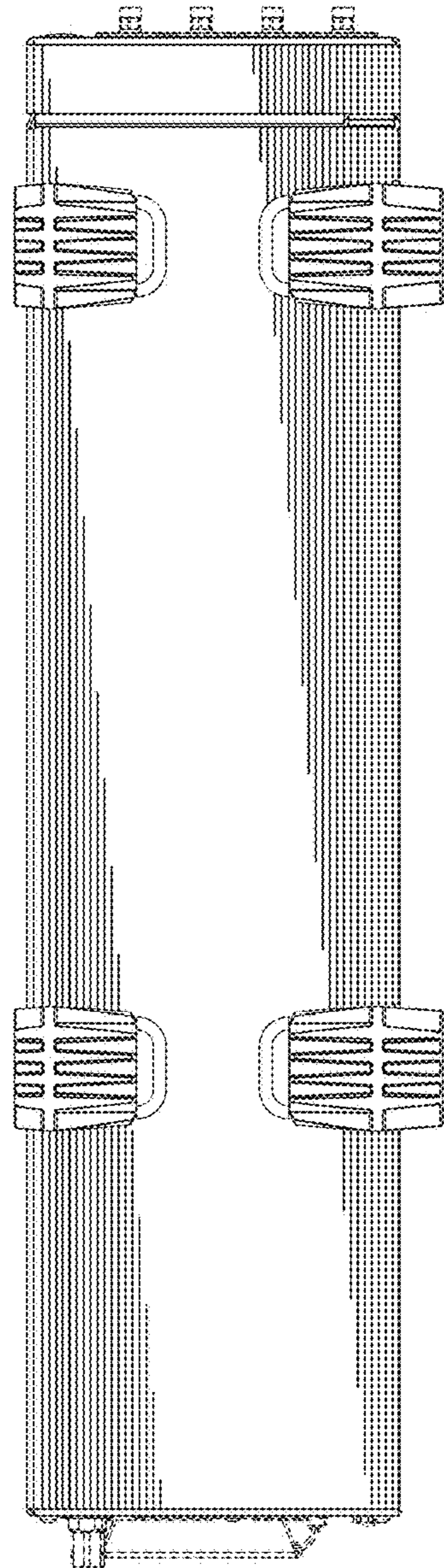


FIG. 6

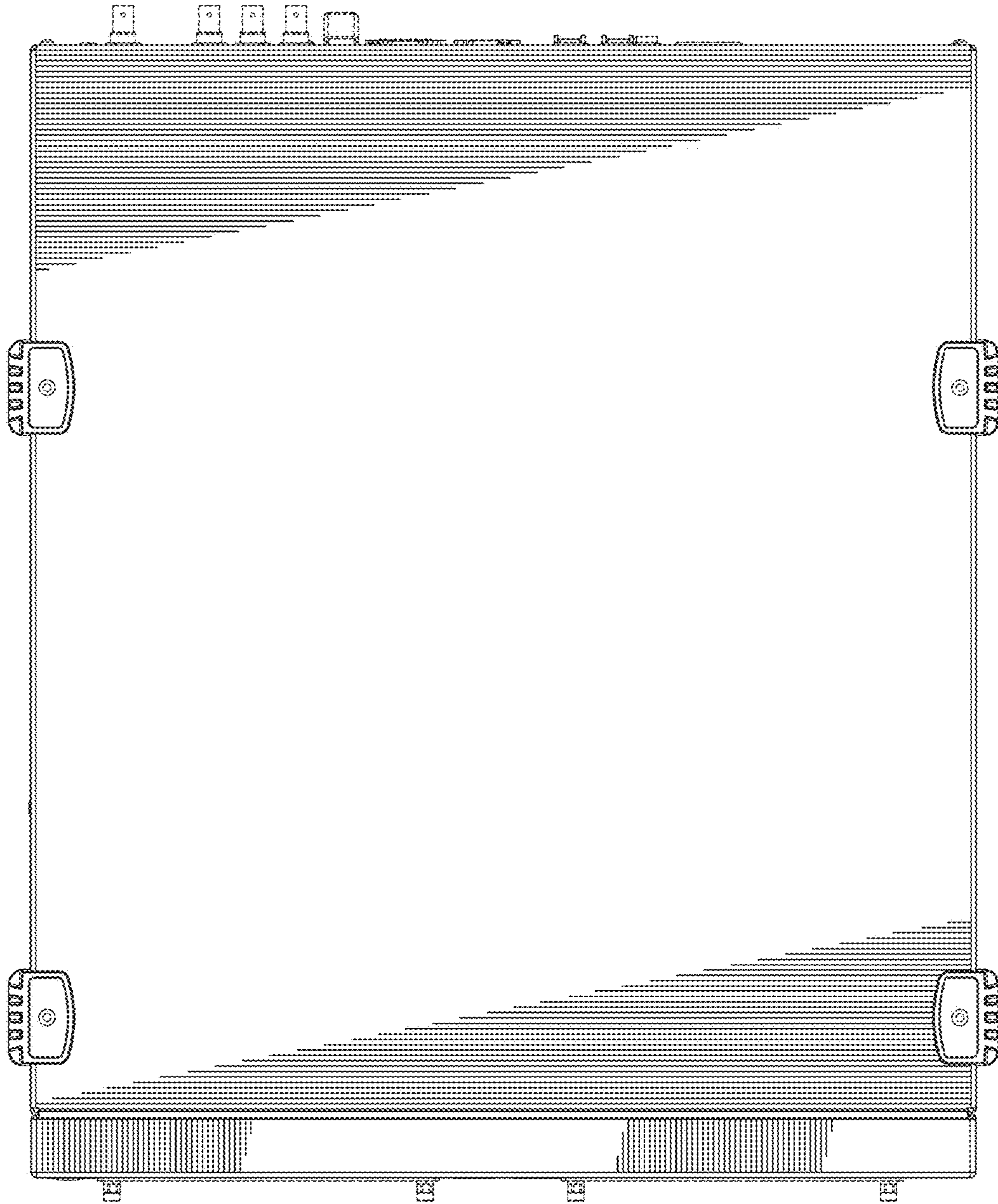
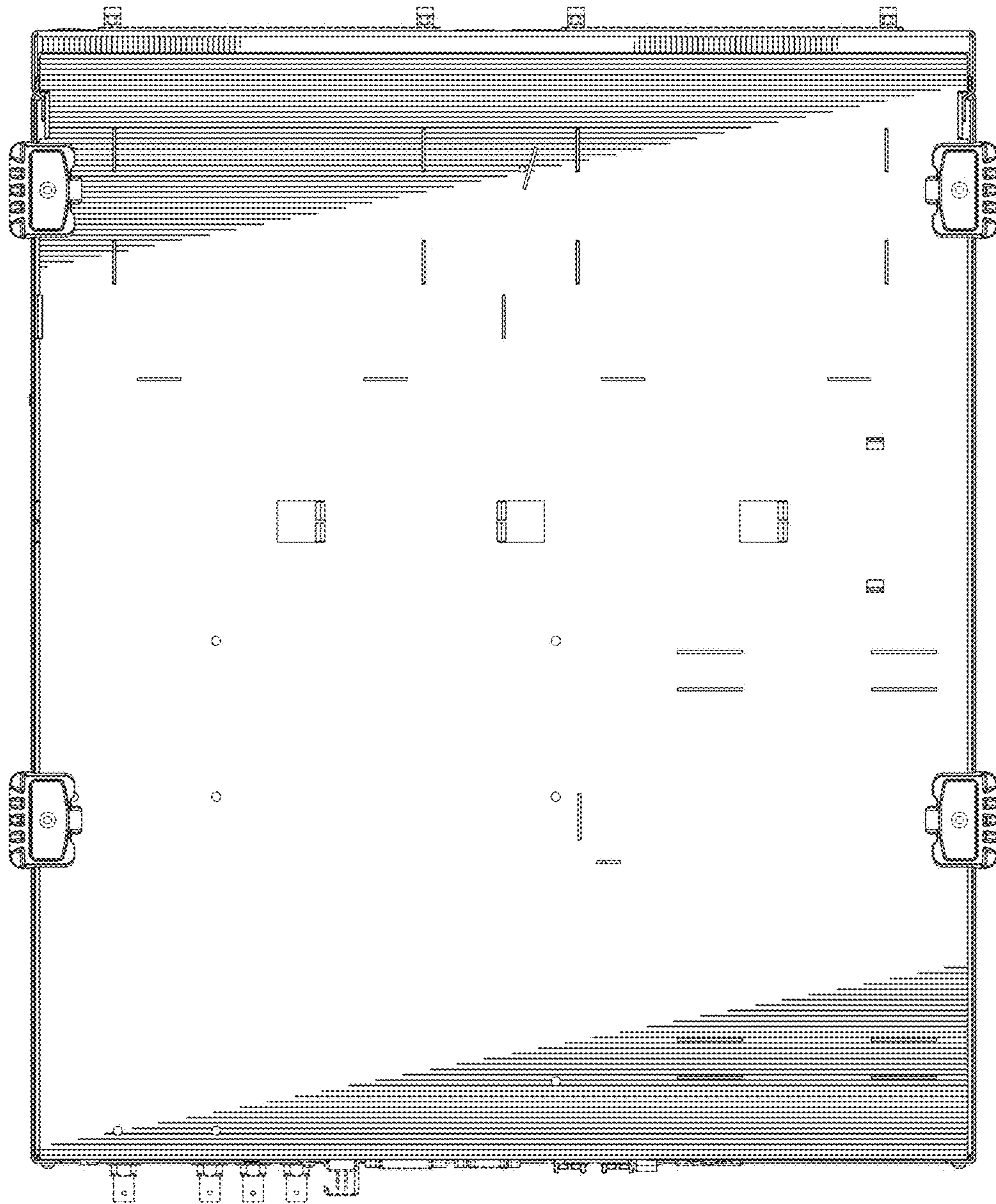
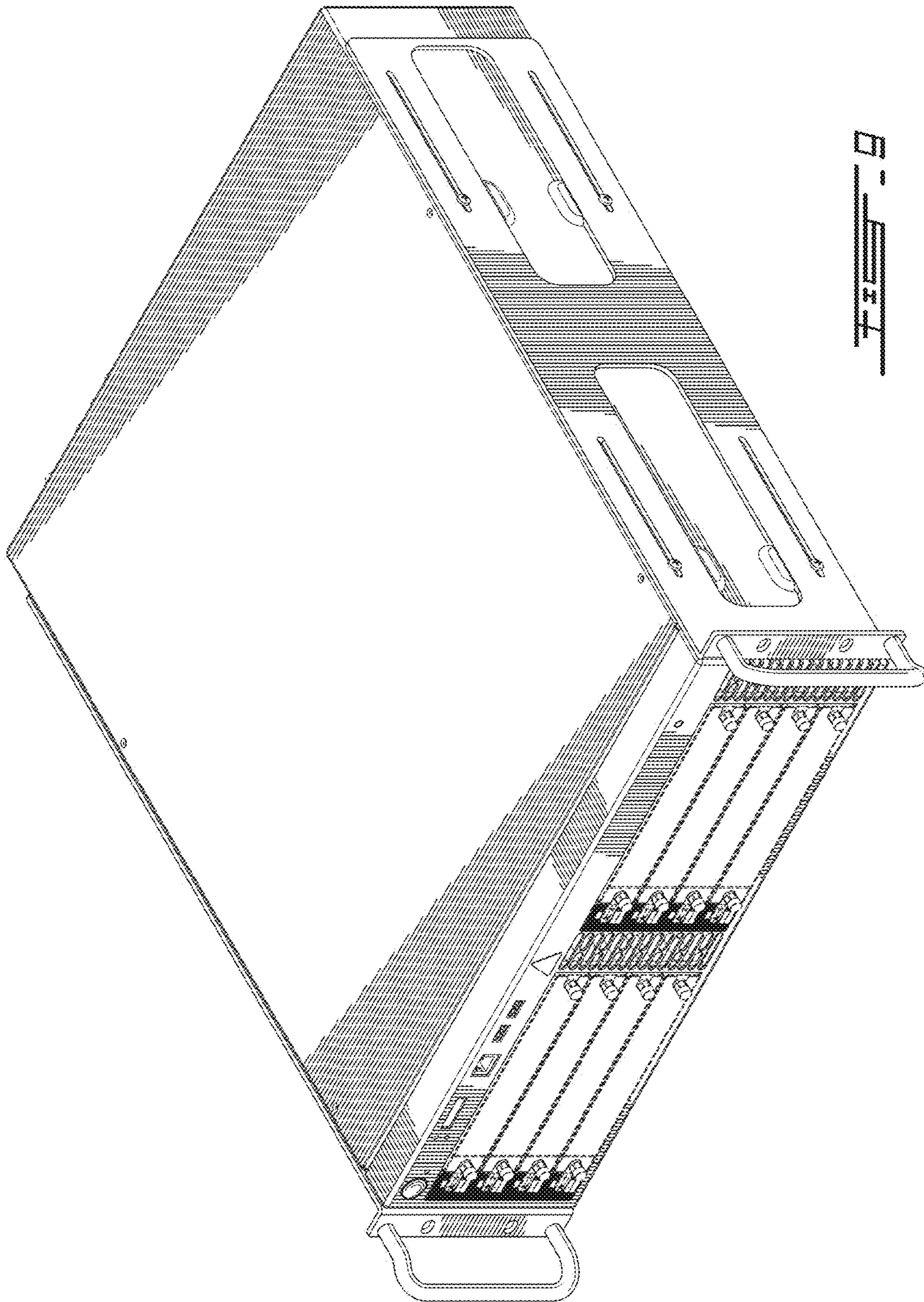
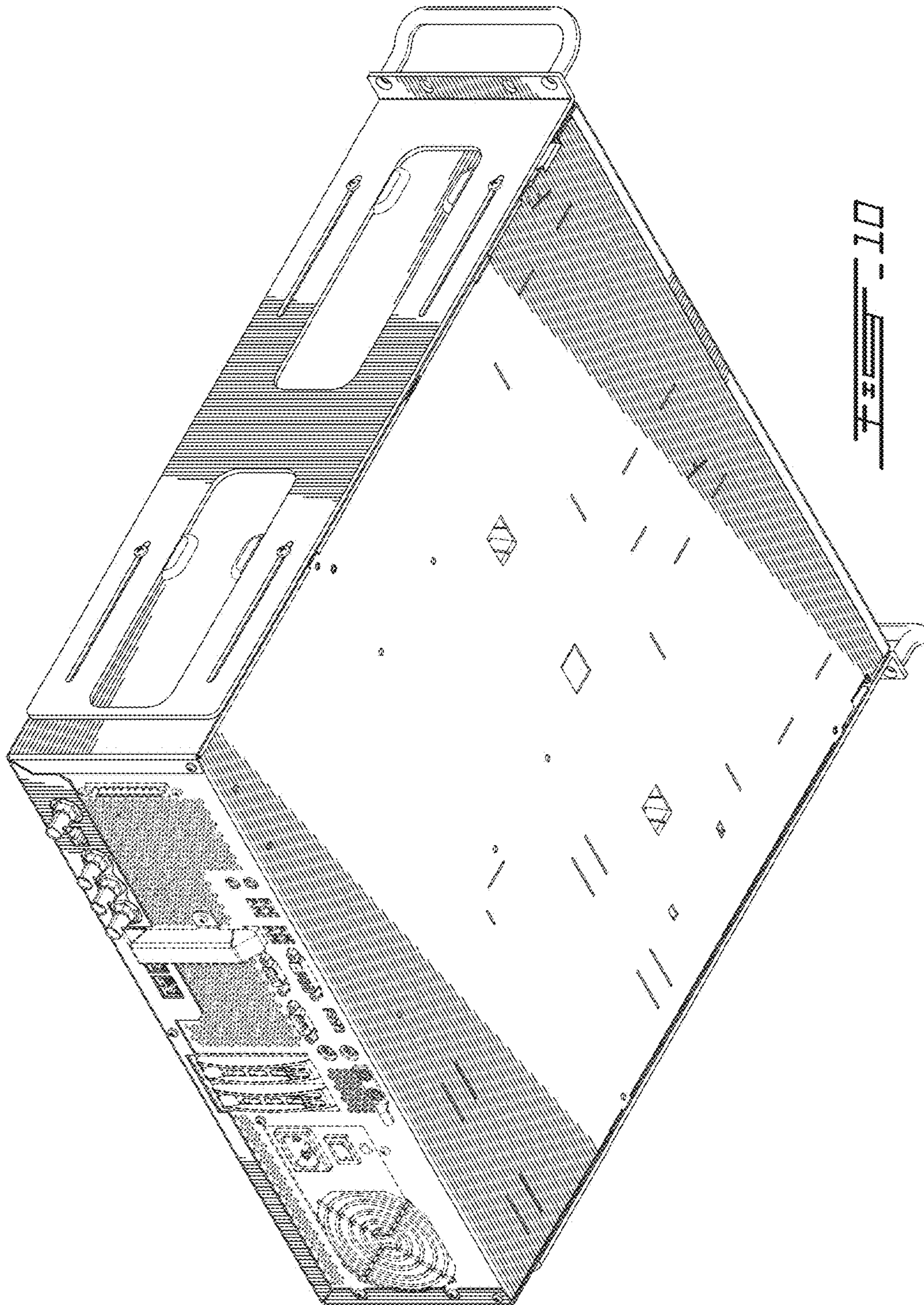


FIG. 7







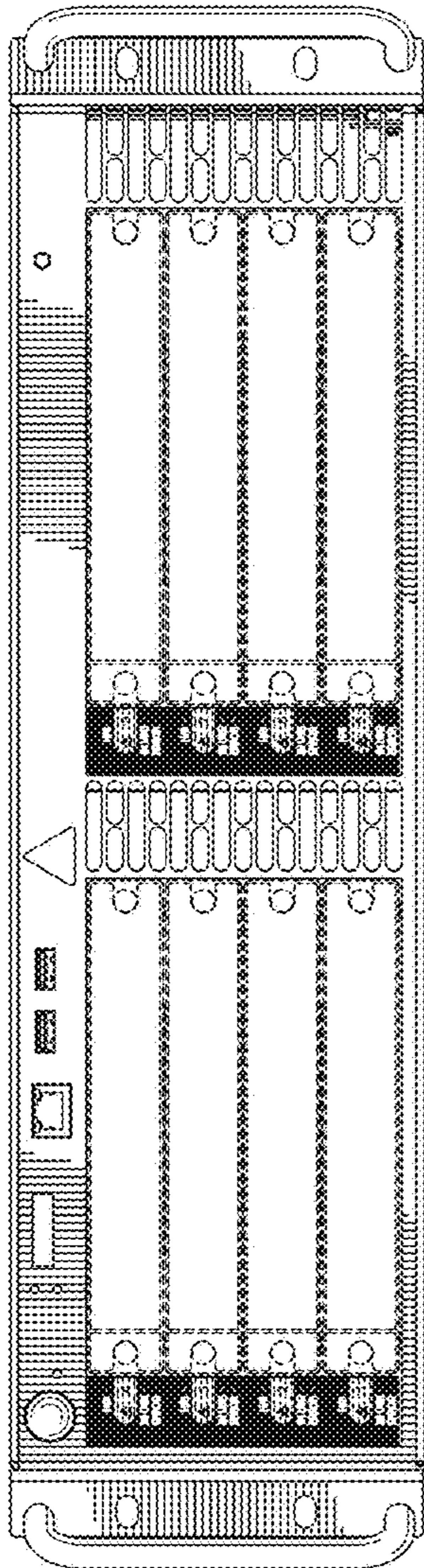


FIG. 11

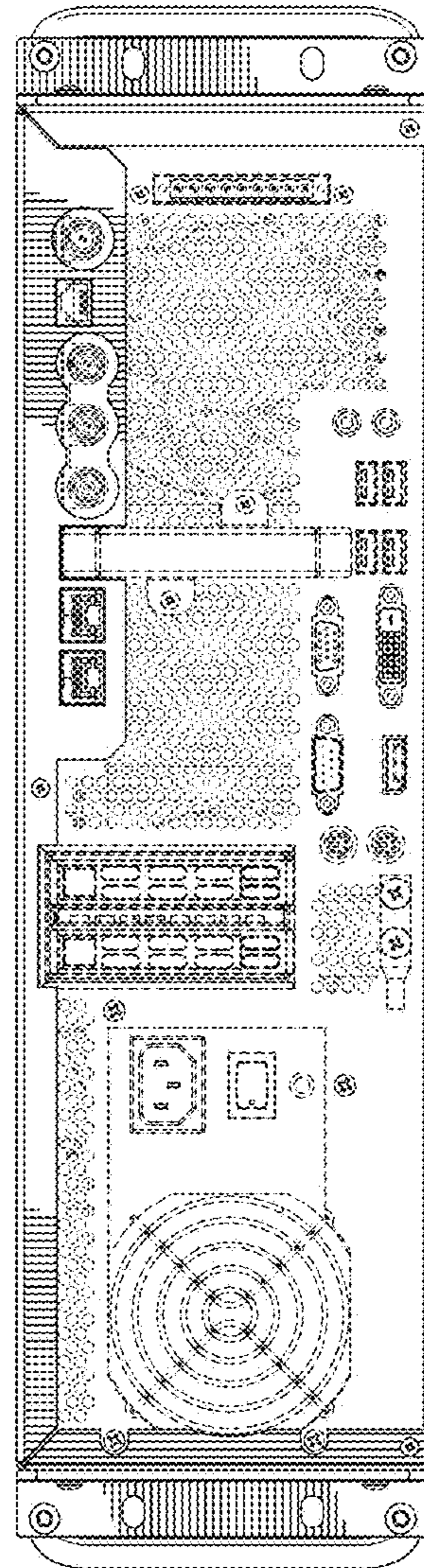


FIG. 12

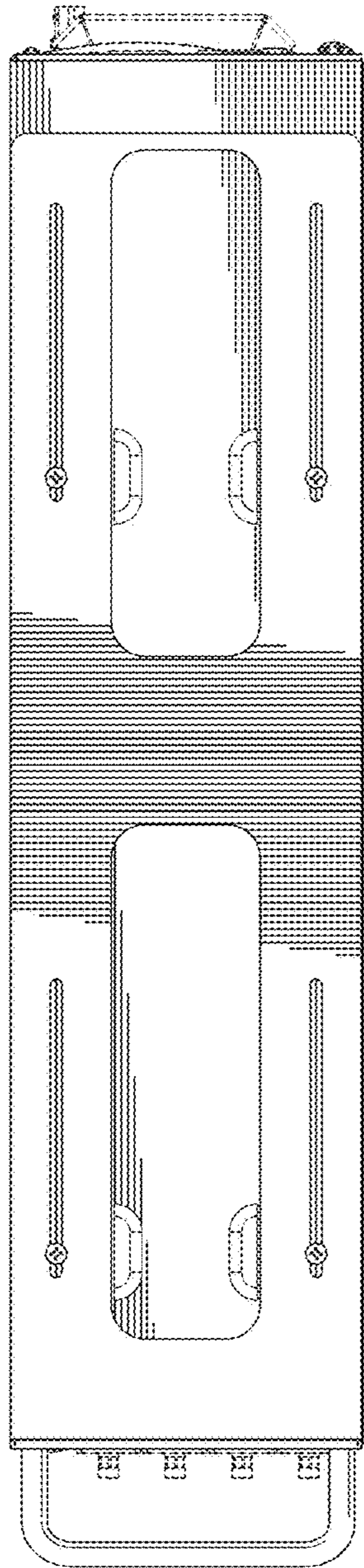


FIG. 13

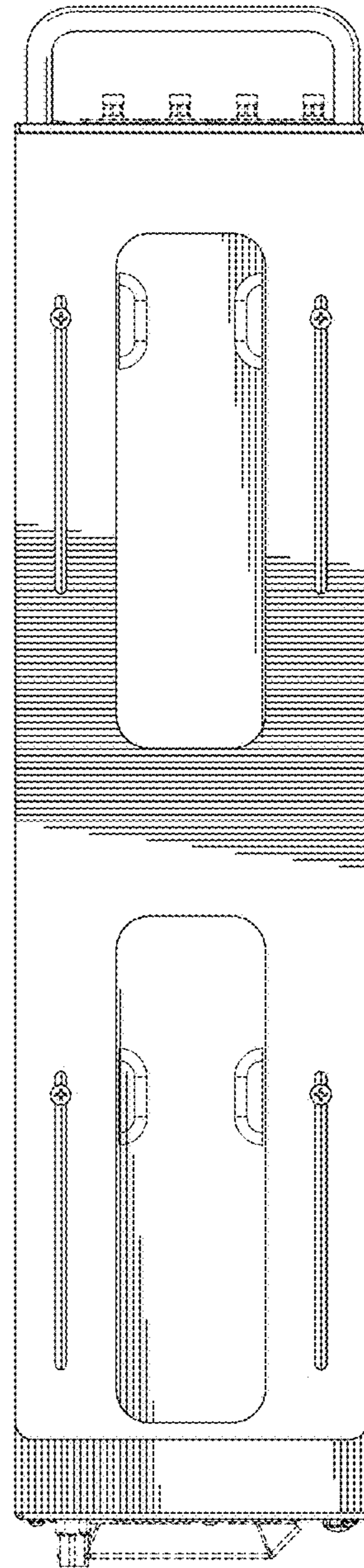
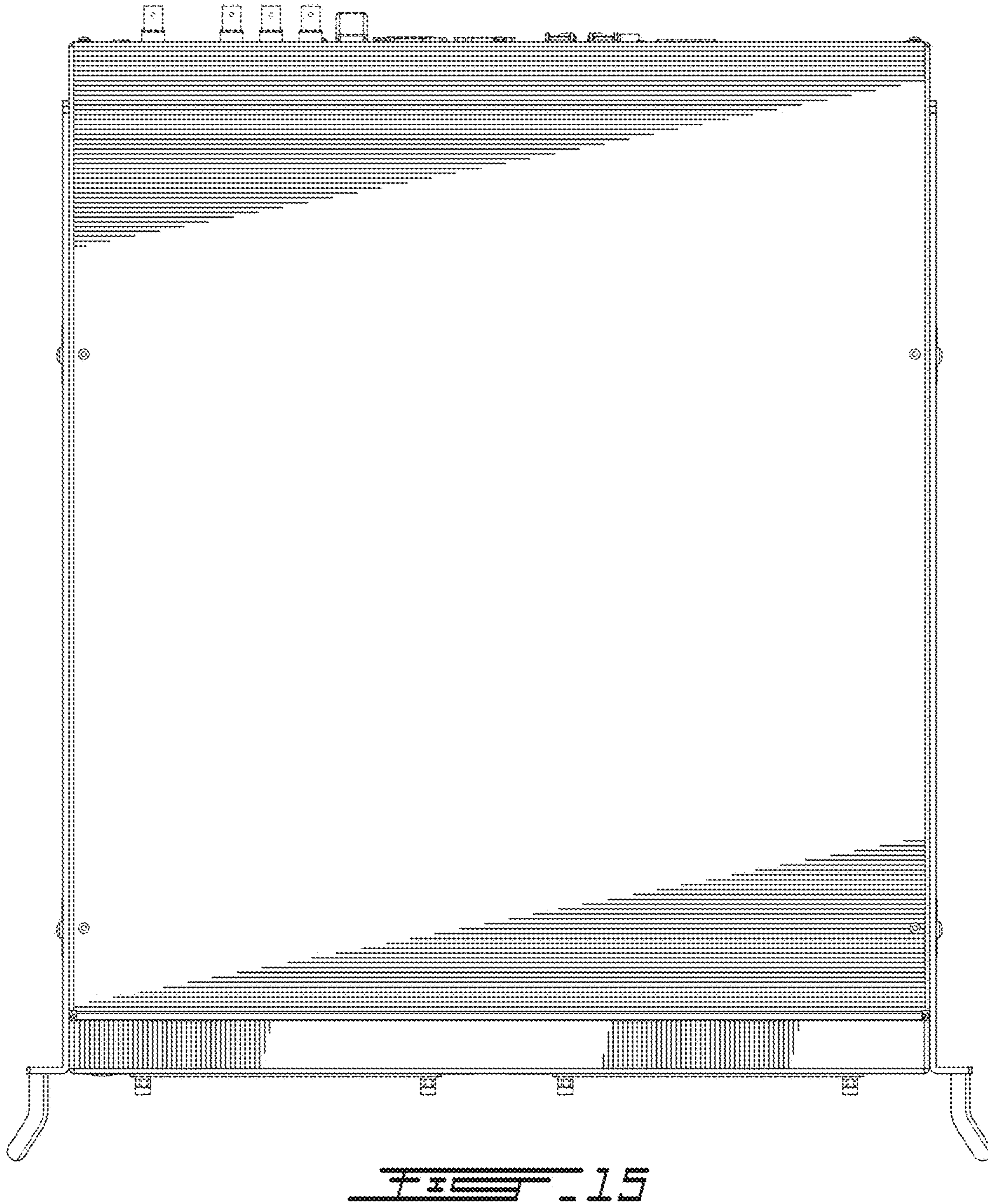


FIG. 14



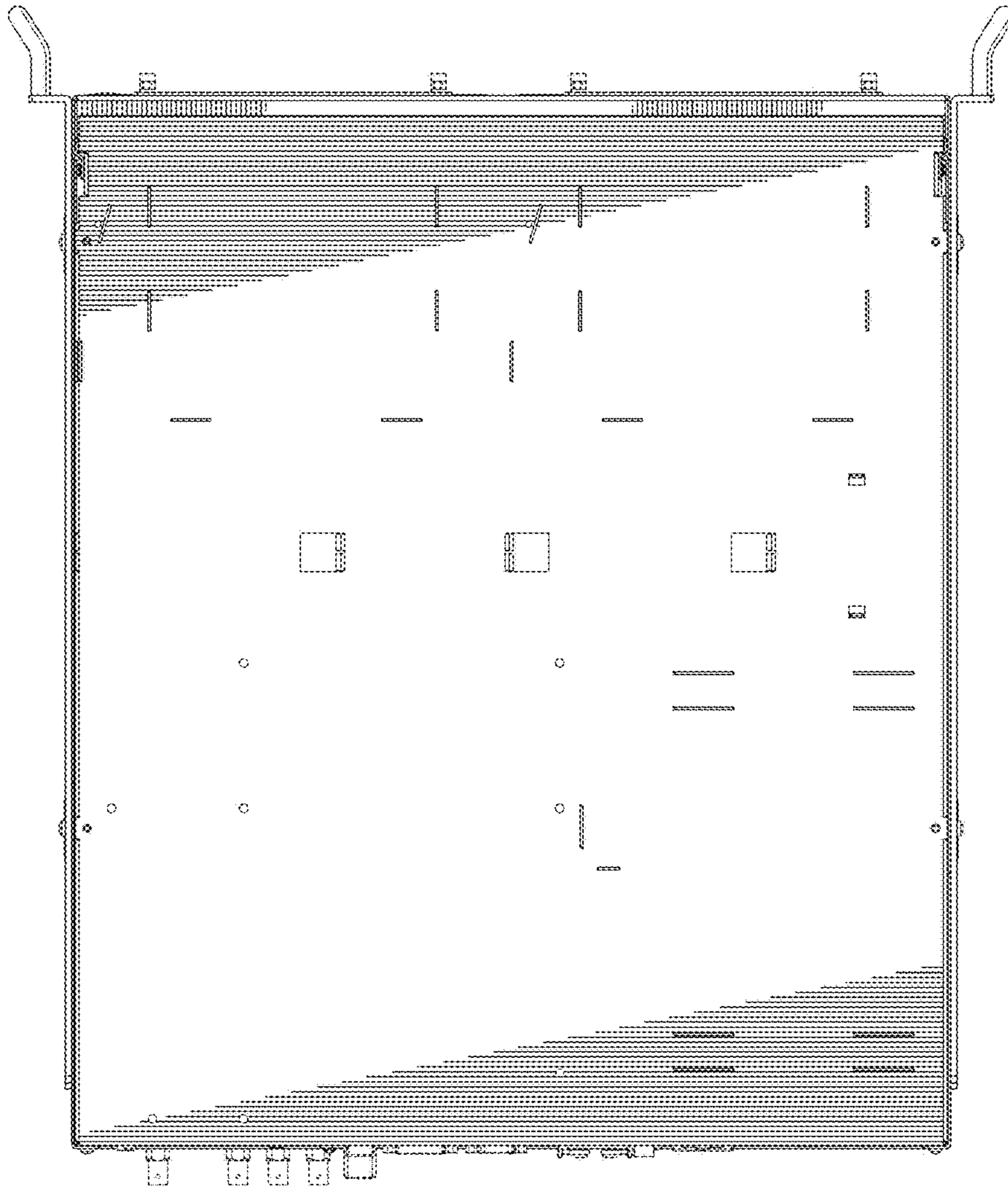


FIG. 10